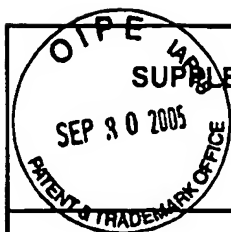


INFORMATION DISCLOSURE CITATION <i>(Use several sheets if necessary)</i>					Docket Number (Optional) PM 2000.062		Application Number 10/016,619	
					Applicants Stephen C. Netemeyer, et al.			
					Filing Date 12/6/01		Group Art Unit	
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*EXAMINER INITIALS	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
<i>[Signature]</i>		5,256,171	10/26/93	Payne	95	19		
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	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation YES NO	
OTHER DOCUMENTS <i>(Including Author, Title, Date, Pertinent Pages, Etc.)</i>								
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Docket Number (Optional)

PM 2000.062

Application Number

10/016,619

Applicants

S. Netemeyer et al

Confirmation No.

6577

Filing Date

Dec. 6, 2001

Group Art Unit

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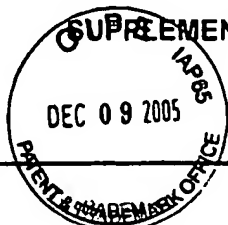
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	Applicants Stephen C. Netemeyer, et al.	
	Filing Date 12/6/01	Group Art Unit

U.S. PATENT DOCUMENTS

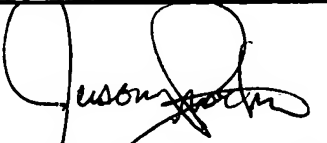
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